Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Pate Reexamination
10/632,643	FRENCH ET AL.	FRENCH ET AL.
Examiner	Art Unit	Art Unit
Daborah Chacko-Davis	1756	1756

Subclass		
	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Updated interference-see updated search history print out		5/7/2007	DCD	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
(430/273.1; 210/664, 663) updated text search only-see updated search history print out	5/4/2007	DCD		
EAST (US-PGPUB, USPAT, FPRS, EPO, JPO, DERWENT, IBM-TDB) See updated search history print out	5/7/2007	DCD		
Consulted with Ms. Cynthia Hamilton	5/4/2007	DCD		
Searched SPIE database	5/4/2007	DCD		
Updated search history print out	5/8/2007	DCD		
Updated eDAN inventor search	5/4/2007	DCD		